

Design-for-destability-based external test and diagnosis of mesh-like network- on-a-chips

Raik, Jaan; Govind, Vineeth; **Ubar, Raimund-Johannes** IET computers and digital techniques 2009 / 5, p. 476-486 : ill
<http://dx.doi.org/10.1049/iet-cdt.2008.0096>

Estimating quality of transmission in a live production network using machine learning

Müller, Jasper; Fehenberger, Tobias; Patri, Sai Kireet; **Kaeval, Kaida**; Griesser, Helmut; Tikas, Marko; Elbers, Jörg-Peter 2021
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p <https://ieeexplore.ieee.org/abstract/document/9489940>

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